## Notice of References Cited

Application/Control No. 10/627,736		Reexamination	Applicant(s)/Patent Under Reexamination SANETO ET AL.		
	Examiner	Art Unit			
	Angel R. Estrada	2831	Page 1 of 1		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,570,088	05-2003	Depp et al.	174/50
	В	US-5,915,978	06-1999	Hayakawa et al.	439/76.2
	С	US-6,515,226	02-2003	Chiriku et al.	174/50
	D	US-6,121,548	09-2000	Matsuoka, Hideo	174/59
	Е	US-6,541,700	04-2003	Chiriku et al.	174/50
	F	US-5,702,021	12-1997	Ito, Hirokazu	220/326
	G	US-5,515,988	05-1996	Oda, Akihiro	220/3.8
	Н	US-6,679,708	01-2004	Depp et al.	439/76.2
	ı	US-6,561,822	05-2003	Depp et al.	439/76.2
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	P					
	Q					
	R					
	s					7,11
	Т				-	

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	·
	w	
	х	

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.